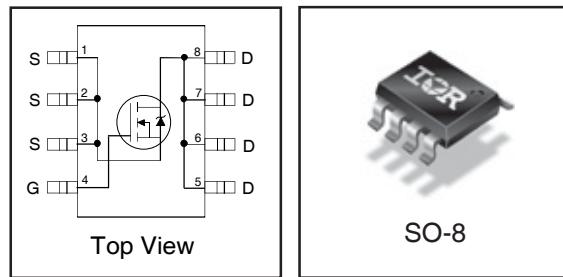


# IRF8707PbF

HEXFET® Power MOSFET

<b>V<sub>DSS</sub></b>	<b>R<sub>DS(on)</sub> max</b>	<b>Q<sub>g</sub></b>
<b>30V</b>	<b>11.9mΩ@V<sub>GS</sub> = 10V</b>	<b>6.2nC</b>



## Applications

- Control MOSFET of Sync-Buck Converters used for Notebook Processor Power
- Control MOSFET for Isolated DC-DC Converters in Networking Systems

## Benefits

- Very Low Gate Charge
- Very Low R<sub>DS(on)</sub> at 4.5V V<sub>GS</sub>
- Ultra-Low Gate Impedance
- Fully Characterized Avalanche Voltage and Current
- 20V V<sub>GS</sub> Max. Gate Rating
- 100% tested for R<sub>g</sub>
- Lead-Free

## Description

The IRF8707PbF incorporates the latest HEXFET Power MOSFET Silicon Technology into the industry standard SO-8 package. The IRF8707PbF has been optimized for parameters that are critical in synchronous buck operation including R<sub>ds(on)</sub> and gate charge to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors for notebook and Netcom applications.

## Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	30	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	11	A
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	9.1	
I <sub>DM</sub>	Pulsed Drain Current ①	88	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Power Dissipation	2.5	W
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Power Dissipation	1.6	
	Linear Derating Factor	0.02	W/°C
T <sub>J</sub>	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		

## Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>0JL</sub>	Junction-to-Drain Lead ⑤	—	20	°C/W
R <sub>0JA</sub>	Junction-to-Ambient ④⑤	—	50	

Notes ① through ⑤ are on page 9

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# IRF8707PbF

International  
Rectifier

Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

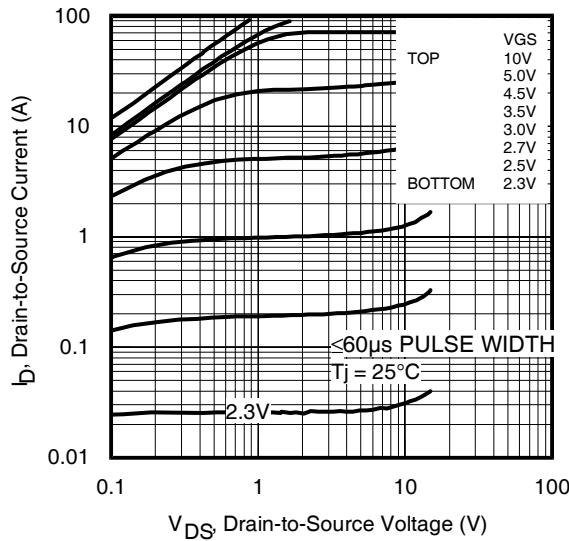
	Parameter	Min.	Typ.	Max.	Units	Conditions
$\text{BV}_{\text{DSS}}$	Drain-to-Source Breakdown Voltage	30	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.022	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS(on)}}$	Static Drain-to-Source On-Resistance	—	9.3	11.9	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 11\text{A}$ ③
		—	14.2	17.5		$V_{\text{GS}} = 4.5\text{V}$ , $I_D = 8.8\text{A}$ ③
$V_{\text{GS(th)}}$	Gate Threshold Voltage	1.35	1.80	2.35	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 25\mu\text{A}$
$\Delta V_{\text{GS(th)}}$	Gate Threshold Voltage Coefficient	—	-5.8	—	mV/ $^\circ\text{C}$	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 25\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	1.0	$\mu\text{A}$	$V_{\text{DS}} = 24\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	150		$V_{\text{DS}} = 24\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 125^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -20\text{V}$
$g_{\text{fs}}$	Forward Transconductance	25	—	—	S	$V_{\text{DS}} = 15\text{V}$ , $I_D = 8.8\text{A}$
$Q_g$	Total Gate Charge	—	6.2	9.3	nC	$V_{\text{DS}} = 15\text{V}$ $V_{\text{GS}} = 4.5\text{V}$ $I_D = 8.8\text{A}$ See Figs. 15 & 16
$Q_{\text{gs}1}$	Pre-V <sub>th</sub> Gate-to-Source Charge	—	1.4	—		
$Q_{\text{gs}2}$	Post-V <sub>th</sub> Gate-to-Source Charge	—	0.7	—		
$Q_{\text{gd}}$	Gate-to-Drain Charge	—	2.2	—		
$Q_{\text{godr}}$	Gate Charge Overdrive	—	1.9	—		
$Q_{\text{sw}}$	Switch Charge ( $Q_{\text{gs}2} + Q_{\text{gd}}$ )	—	2.9	—	pF	$V_{\text{DS}} = 16\text{V}$ , $V_{\text{GS}} = 0\text{V}$
$Q_{\text{oss}}$	Output Charge	—	3.7	—		
$R_g$	Gate Resistance	—	2.2	3.7		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	6.7	—		$V_{\text{DD}} = 15\text{V}$ , $V_{\text{GS}} = 4.5\text{V}$ $I_D = 8.8\text{A}$ $R_G = 1.8\Omega$ See Fig. 18
$t_r$	Rise Time	—	7.9	—		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	7.3	—		
$t_f$	Fall Time	—	4.4	—		
$C_{\text{iss}}$	Input Capacitance	—	760	—	pF	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 15\text{V}$ $f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	170	—		
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	82	—		

## Avalanche Characteristics

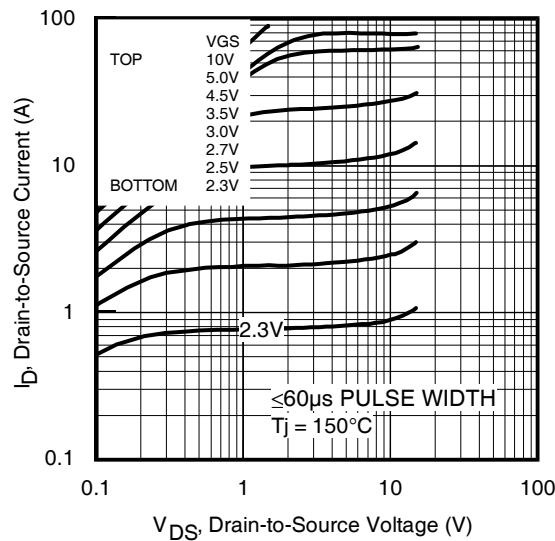
	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy ②	—	53	mJ
$I_{\text{AR}}$	Avalanche Current ①	—	8.8	A

## Diode Characteristics

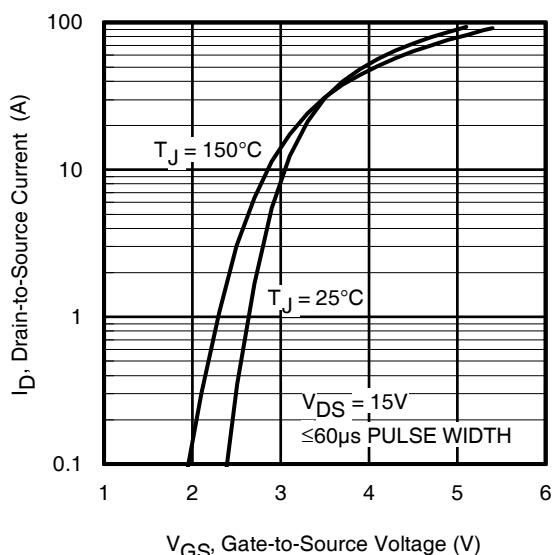
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s$	Continuous Source Current (Body Diode)	—	—	3.1	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	88	A	
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.0	V	$T_J = 25^\circ\text{C}$ , $I_S = 8.8\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ③
$t_{\text{rr}}$	Reverse Recovery Time	—	12	18	ns	$T_J = 25^\circ\text{C}$ , $I_F = 8.8\text{A}$ , $V_{\text{DD}} = 15\text{V}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	13	20	nC	$di/dt = 300\text{A}/\mu\text{s}$ ③
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				



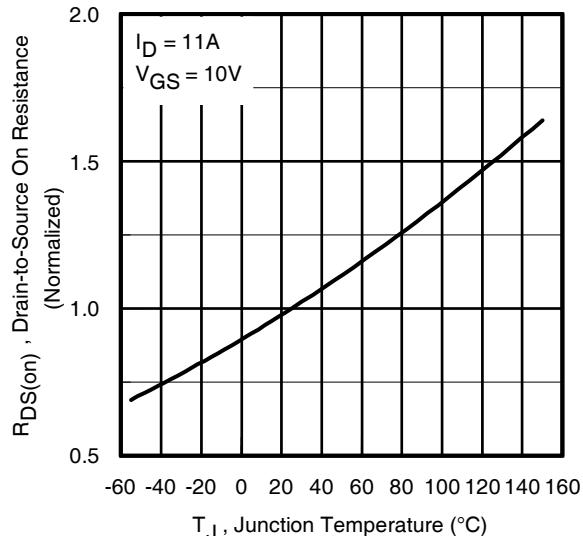
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



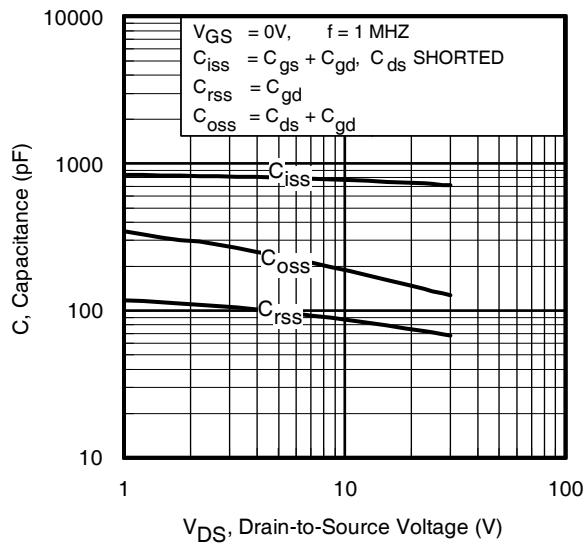
**Fig 3.** Typical Transfer Characteristics



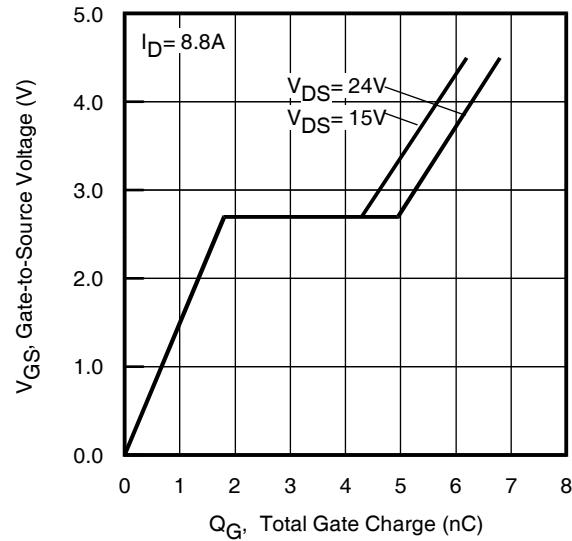
**Fig 4.** Normalized On-Resistance  
vs. Temperature

# IRF8707PbF

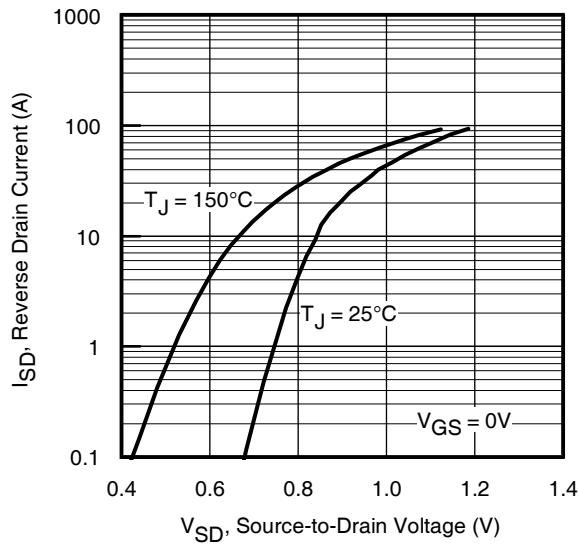
International  
Rectifier



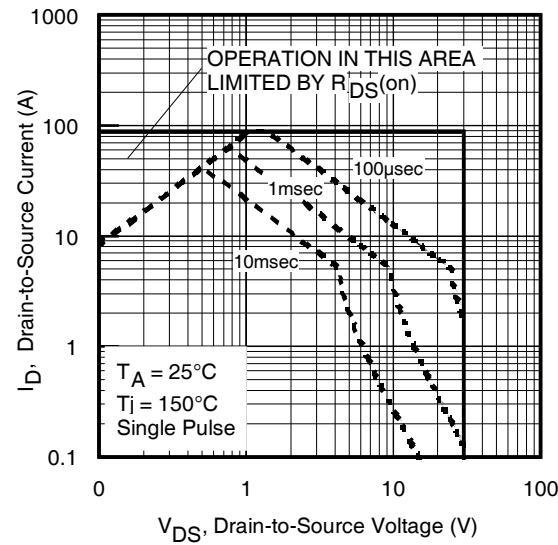
**Fig 5.** Typical Capacitance vs.  
Drain-to-Source Voltage



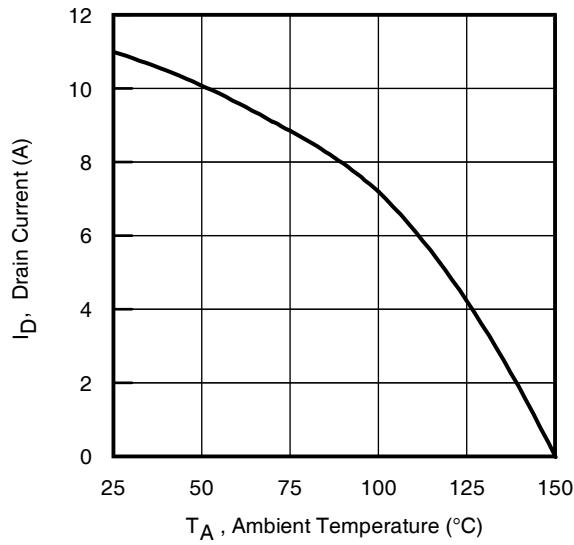
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



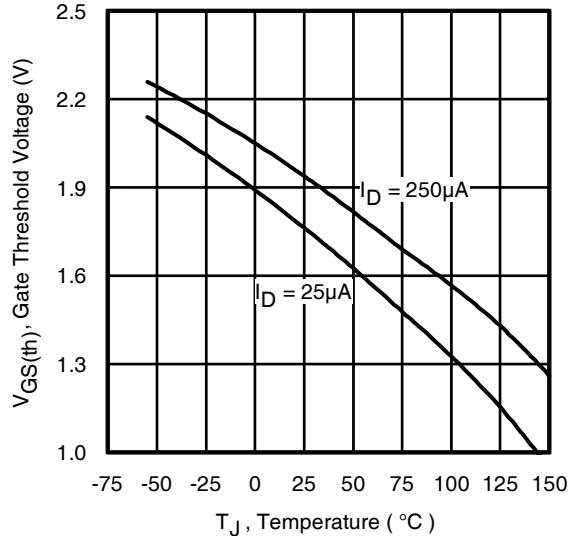
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



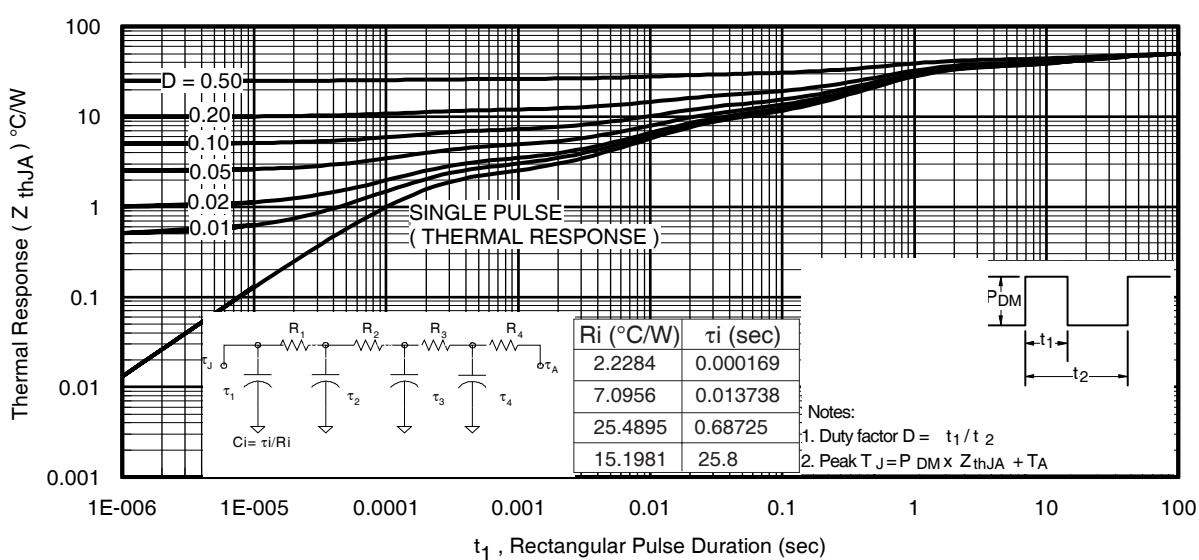
**Fig 8.** Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current vs.  
Ambient Temperature



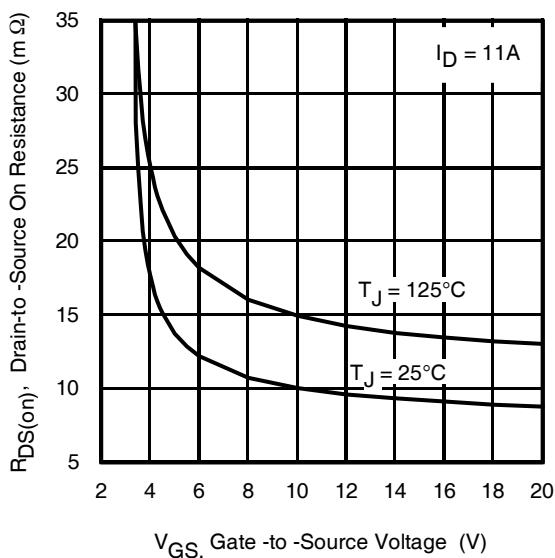
**Fig 10.** Threshold Voltage vs. Temperature



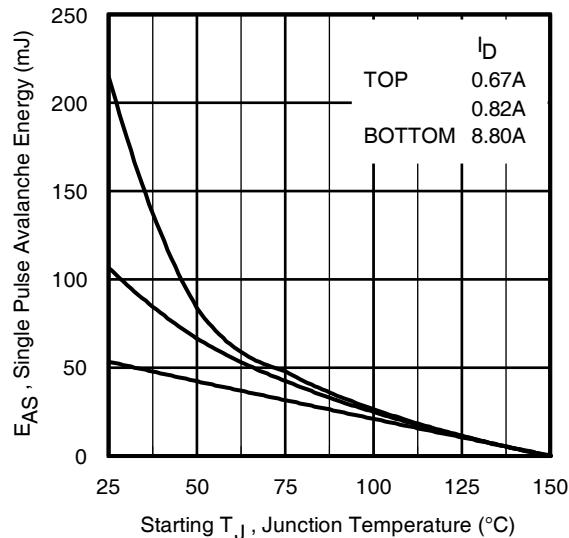
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

# IRF8707PbF

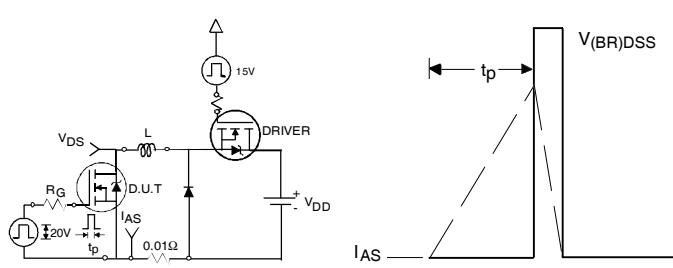
International  
Rectifier



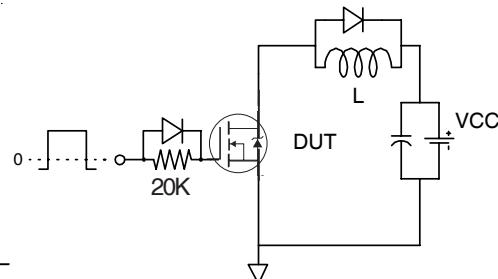
**Fig 12.** On-Resistance vs. Gate Voltage



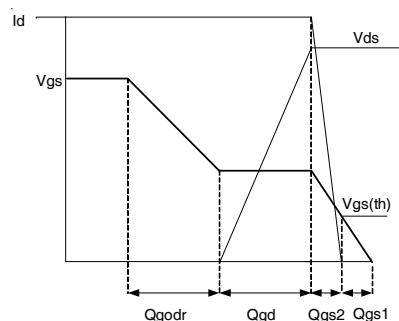
**Fig 13.** Maximum Avalanche Energy vs. Drain Current



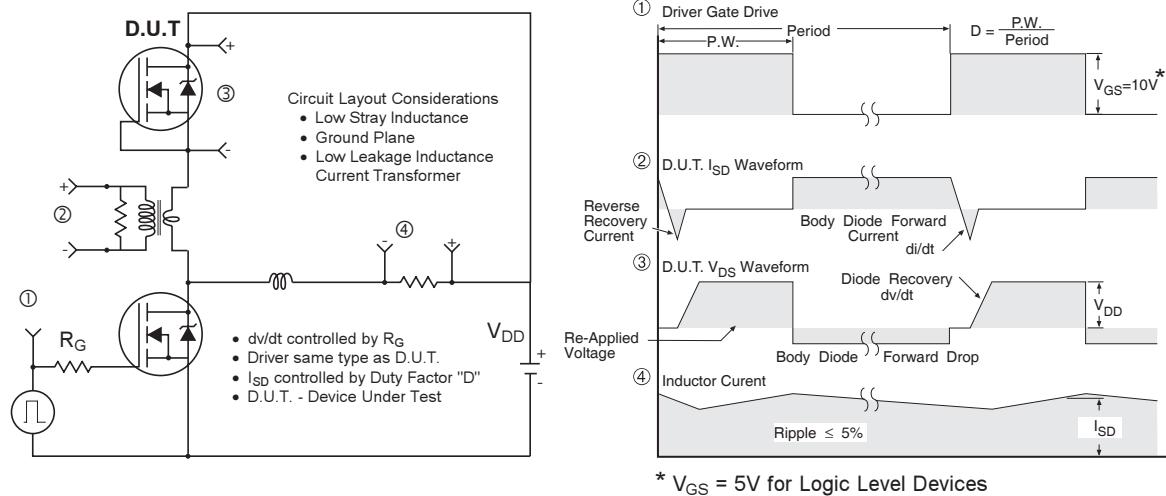
**Fig 14.** Unclamped Inductive Test Circuit and Waveform



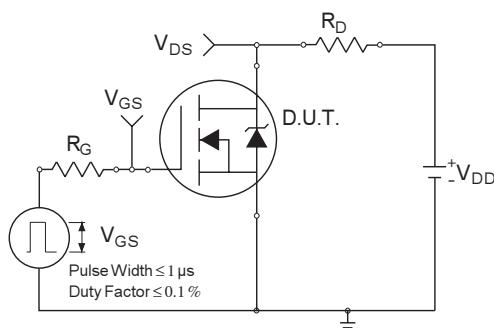
**Fig 15.** Gate Charge Test Circuit



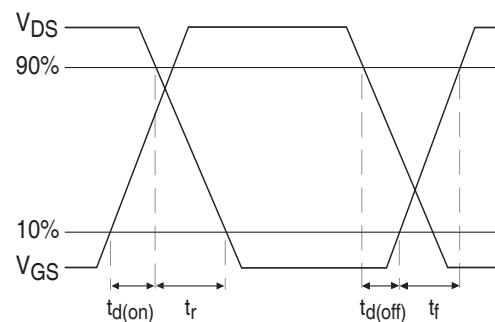
**Fig 16.** Gate Charge Waveform



**Fig 17.** Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs



**Fig 18a.** Switching Time Test Circuit



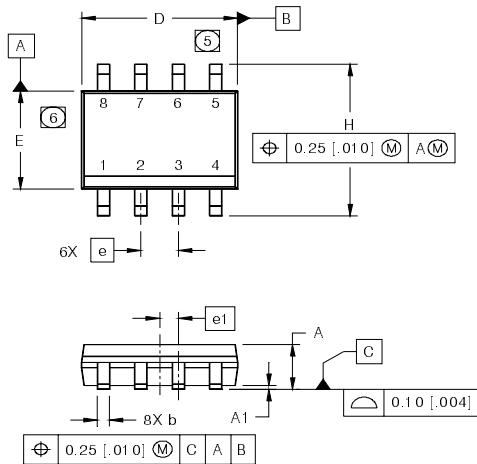
**Fig 18b.** Switching Time Waveforms

# IRF8707PbF

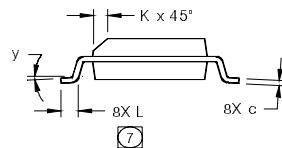
## SO-8 Package Outline

Dimensions are shown in millimeters (inches)

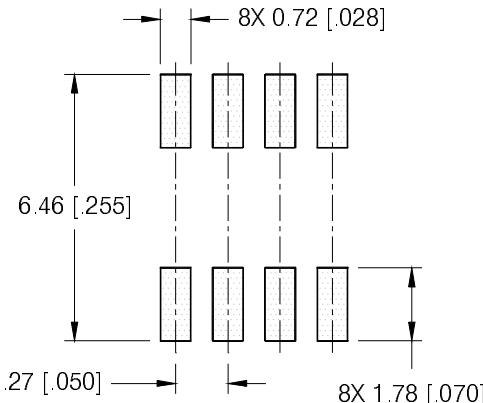
International  
**IR** Rectifier



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°

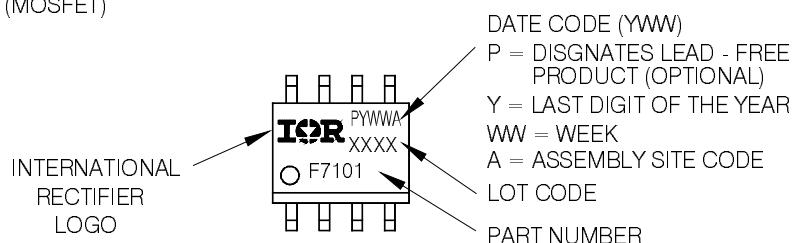


FOOTPRINT



## SO-8 Part Marking Information

EXAMPLE: THIS IS AN IRF7101 (MOSFET)

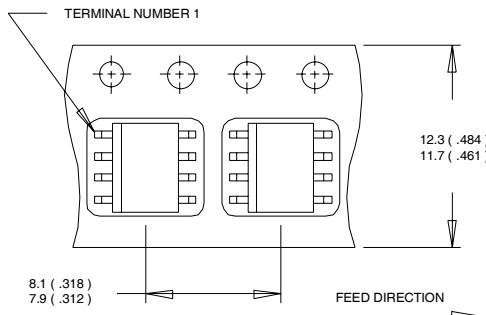


Note: For the most current drawing please refer to IR website at <http://www.irf.com/package>

International  
**IR** Rectifier

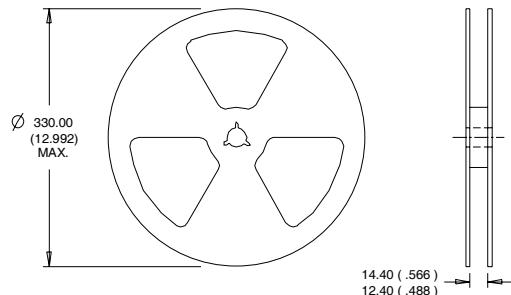
## SO-8 Tape and Reel

Dimensions are shown in millimeters (inches)



NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 1.38\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 8.8\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ When mounted on 1 inch square copper board.
- ⑤  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package>

Data and specifications subject to change without notice.

This product has been designed and qualified for the Consumer market.

Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

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